

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10542260	AN, CHI-YUP
	Examiner	Art Unit
	Gail Verbitsky	2855

SEARCHED

Class	Subclass	Date	Examiner
374	147	11/18/08	gv

SEARCH NOTES

Search Notes	Date	Examiner

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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